Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/065,908	LEE, HENG-KUAN	
Examiner	Art Unit	
 Patrick H. Cathey II	2613	

	SEARCHED		
Class	Subclass	Date	Examiner
375	240.16	10/14/2004	МЈН
375	240.17	10/14/2004	MJH
updated		6/27/2005	PHC
updated		9/1/2005	PHC

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
375	240.16	9/1/2005	РНС	
375	240.17	9/1/2005	PHC	

SEARCH NOT)
	DATE	EXMR
See attached search history notes	10/14/2004	MJH
IEEE search: motion, estimation, fine, course, fast, Also preformed inventor search	10/14/2005	MJH
ACM Library Search: motion, estimation, fast, fine, course	10/14/2005	MJH
updated ·	6/27/2005	PHC
updated	9/1/2005	РНС